

<b>Notice of References Cited</b>		Application/Control No. 09/934,693	Applicant(s)/Patent Under Reexamination AHN, KEUN HEE	
		Examiner Jacob Meek	Art Unit 2637	Page 1 of 1

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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages).
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